Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10678518	NAGAI ET AL.
	Examiner	Art Unit
	Hopkins, Johnny R	2609

SEARCHED

Class	Subclass	Date	Examiner
386	52	12/20/2007	gw
707	104.100	12/20/2007	gw

SEARCH NOTES

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US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	12/13/2007	gw
Inventor(s) search	12/20/2007	gw
Consulted: James Fletcher; Thai Tran	12/20/2007	gw

INTERFERENCE SEARCH

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